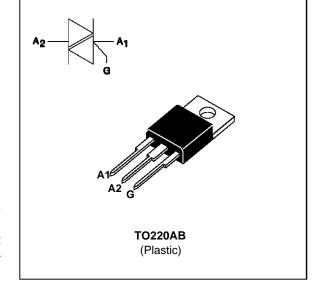


# LOGIC LEVEL TRIACS

#### **FEATURES**

- LOW I<sub>GT</sub> = 10mA max
- HIGH EFFICIENCY SWITCHING ON COMMUTATION
- BTA Family: INSULATING VOLTAGE = 2500V(RMS) (UL RECOGNIZED: E81734)



#### **DESCRIPTION**

The BTA/BTB12 SW Triac family are high performance products glass passivated PNPN devices. These parts are suited for low power trigger circuit (integrated circuits, microcontroller, microprocessors.

### **ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter			Value	Unit
I <sub>T(RMS)</sub>	RMS on-state current	ВТА	Tc = 70 °C	12	Α
	(360° conduction angle)	втв	Tc = 75 °C		
ITSM	ITSM Non repetitive surge peak on-state current (Tj initial = 25°C)		tp = 8.3 ms	126	Α
			tp = 10 ms	120	
l <sup>2</sup> t	I <sup>2</sup> t value	value		72	A <sup>2</sup> s
dl/dt	Critical rate of rise of on-state current Gate supply: I <sub>G</sub> = 50mA di <sub>G</sub> /dt = 0.1A/μs		Repetitive F = 50 Hz	20	A/μs
	Non Repetitive			100	
Tstg Tj	Storage and operating junction temperature range			- 40 to + 150 - 40 to + 110	°C °C
TI	Maximum lead temperature for soldering during 10 s at 4.5 mm from case			260	°C

Symbol	Parameter		BTA / BTB12-				
		400 SW	600 SW	700 SW			
VDRM VRRM	Repetitive peak off-state voltage Tj = 110 °C	400	600	700	V		

March 1995

## THERMAL RESISTANCES

Symbol	Parameter	Value	Unit	
Rth (j-a)	Junction to ambient	60	°C/W	
Rth (j-c) DC	Junction to case for DC	вта	3.3	°C/W
		втв	2.7	
Rth (j-c) AC	Junction to case for 360° conduction angle	ВТА	2.5	°C/W
( F= 50 Hz)		втв	2	

# **GATE CHARACTERISTICS** (maximum values)

 $PG~(AV) = 1W~~PGM = 10W~(tp = 20~\mu s)~~I_{GM} = 4A~(tp = 20~\mu s)~~V_{GM} = 16V~(tp = 20~\mu s).$ 

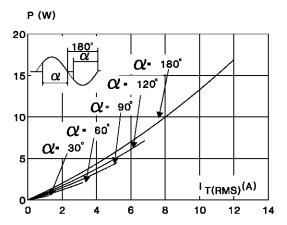
# **ELECTRICAL CHARACTERISTICS**

Symbol	Test Conditions		Quadrant		Suffix	Unit
					sw	
l <sub>GT</sub>	$V_D=12V$ (DC) $R_L=33\Omega$	Tj=25°C	1-11-111	MAX	10	mA
V <sub>GT</sub>	$V_D=12V$ (DC) $R_L=33\Omega$	Tj=25°C	1-11-111	MAX	1.5	V
V <sub>GD</sub>	V <sub>D</sub> =V <sub>DRM</sub> R <sub>L</sub> =3.3kΩ	Tj=110°C	1-11-111	MIN	0.2	V
tgt	$V_D=V_{DRM}$ $I_G=40$ mA $dI_G/dt=0.5$ A/ $\mu$ s	Tj=25°C	1-11-111	TYP	2	μs
IL	IG=1.2 IGT	Tj=25°C	1-111	TYP	15	mA
			II		25	
lH *	IT= 100mA gate open	Tj=25°C		MAX	25	mA
VTM *	I <sub>TM</sub> = 17A tp= 380μs	Tj=25°C		MAX	1.75	V
!DRM	VDRM Rated	Tj=25°C		MAX	0.01	mA
IRRM	V <sub>RRM</sub> Rated	Tj=110°C		MAX	1	
dV/dt *	Linear slope up to VD=67%VDRM gate open	Tj=110°C		MIN	50	V/μs
(dl/dt)c *	dV/dt= 0.1V/μs	Tj=110°C		MIN	5.3	A/ms
	dV/dt= 20V/μs			MIN	3.5	

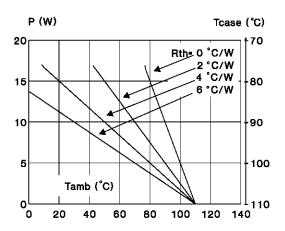
 $<sup>^{\</sup>star}$  For either polarity of electrode  $A_2$  voltage with reference to electrode  $A_1.$ 

 $\label{eq:Fig.1} \textbf{Fig.1:} \ \, \text{Maximum RMS power dissipation versus RMS} \\ \text{on-state current (F=50Hz)}.$ 

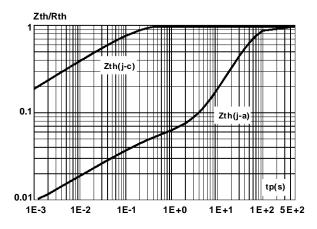
(Curves are cut off by (dl/dt)c limitation)



**Fig.3**: Correlation between maximum RMS power dissipation and maximum allowable temperatures ( $T_{amb}$  and  $T_{case}$ ) for different thermal resistances heatsink + contact (BTB).



**Fig.5**: Relative variation of thermal impedance versus pulse duration.



**Fig.2**: Correlation between maximum RMS power dissipation and maximum allowable temperatures ( $T_{amb}$  and  $T_{case}$ ) for different thermal resistances heatsink + contact (BTA).

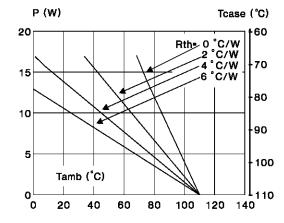
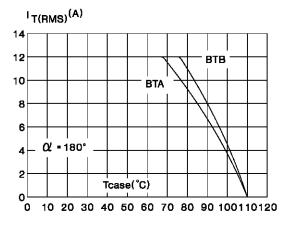


Fig.4: RMS on-state current versus case temperature.



**Fig.6**: Relative variation of gate trigger current and holding current versus junction temperature.

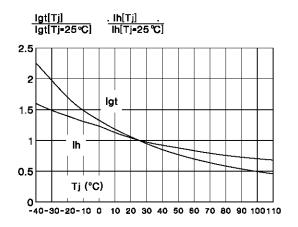


Fig.7: Non Repetitive surge peak on-state current versus number of cycles.

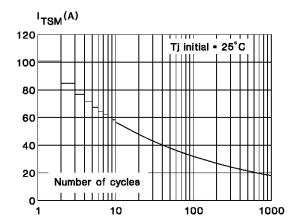
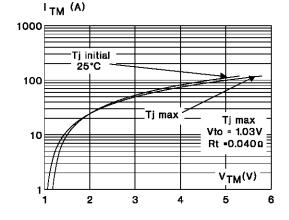
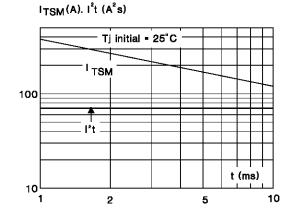


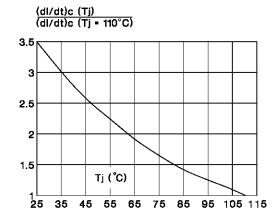
Fig.9: On-state characteristics (maximum values).



**Fig.8 :** Non repetitive surge peak on-state current for a sinusoidal pulse with width :  $t \le 10ms$ , and corresponding value of  $I^2t$ .

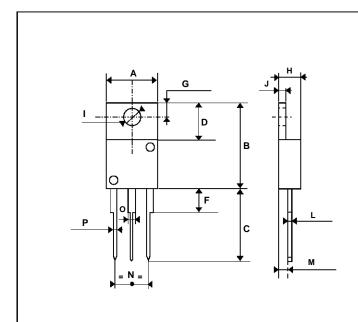


 $\label{eq:Fig.10:Relative variation} \textbf{Fig.10:} Relative variation of $(dI/dt)c$ versus junction temperature.$ 



#### PACKAGE MECHANICAL DATA

TO220AB Plastic



REF.	DIMENSIONS				
	Millimeters		Inc	hes	
	Min. Max.		Min.	Max.	
Α	10.20	10.50	0.401	0.413	
В	14.23	15.87	0.560	0.625	
С	12.70	14.70	0.500	0.579	
D	5.85	6.85	0.230	0.270	
F		4.50		0.178	
G	2.54	3.00	0.100	0.119	
Н	4.48	4.82	0.176	0.190	
- 1	3.55	4.00	0.140	0.158	
J	1.15	1.39	0.045	0.055	
L	0.35	0.65	0.013	0.026	
М	2.10	2.70	0.082	0.107	
N	4.58	5.58	0.18	0.22	
0	0.80	1.20	0.031	0.048	
Р	0.64	0.96	0.025	0.038	

Cooling method: C Marking: type number

Weight: 2.3 g

Recommended torque value : 0.8 m.N. Maximum torque value : 1 m.N.

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